

APPROVAL SHEET

WLPN202012 Series Shielded SMD Power Inductors

*Contents in this sheet are subject to change without prior notice.

Features

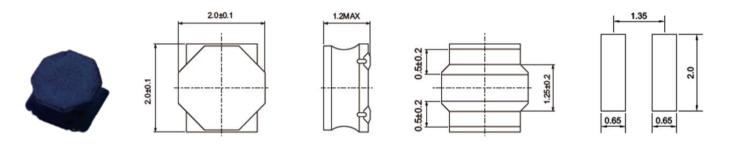
- 1. Close magnetic loop with magnetic resin shielded.
- 2. Low profile, High inductance.

Applications

- 1. General propose power inductor in DC power system.
- 2. Inductor in DC/DC converter.
- 3. Low profile for portable and wearable device.
- 4. LC filter in Audio D class Amplifier.

Shape and Dimension

Unit: mm



Ordering Information

WL	PN	2020	12	Ν	1R0	Р	В
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	Shielded SMD Power Inductors	2.0 * 2.0 mm	1.2 mm	M: ± 20% N: ± 30%	1R0 = 1.0uH	P=7" Reeled (Embossed tape)	B:STD

Electrical Characteristics

WLPN202012	L	Inductance	D.C.R	Test	Rated Current(mA)				
Series	Series (uH) Tolerance		±20%(Ω)	Freq (KHz)	Saturation Current Idc1 (Typ.)	Temperature Rise Current Idc2 (Typ.)	Saturation Current Idc1(Max.)	Temperature Rise Current Idc2(Max.)	
WLPN202012N1R0PB	1.0	±30%	0.070	100	2050	1850	1900	1700	
WLPN202012N1R5PB	1.5	±30%	0.090	100	1800	1650	1650	1500	
WLPN202012M2R2PB	2.2	±20%	0.107	100	1500	1500	1350	1370	
WLPN202012M3R3PB	3.3	±20%	0.190	100	1150	1100	1000	1020	
WLPN202012M4R7PB	4.7	±20%	0.241	100	1050	1000	900	910	

1. Test Frequency: 100 KHz.

2. Test Equipment:

Inductance: Chroma3302+1320+16502 or equivalent.

DCR: Chroma16502 or equivalent.

3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.

4. Temperature rise current ldc2: The value of current causes a 40 $^\circ\!\mathrm{C}$ temperature rise.

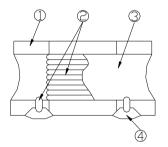
5. Rated Current: Either Idc1 or Idc2 whichever is smaller.

6. Operating Temperature Range:-25 $^\circ\!\mathrm{C}$ to +125 $^\circ\!\mathrm{C}$ (Including self-temperature rise).

7. Storage Temp. Range : -40° C to $+85^{\circ}$ C.

8. MSL : Level 1.

Structural Drawing



① Ferrite core : Ni-Zn ferrite.

② Winding wire : Polyurethane-copper wire.

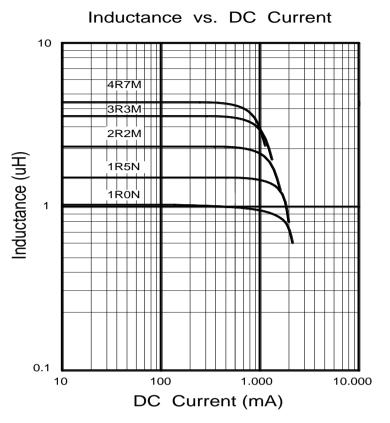
③ Over-coating resin : Epoxy resin, containing ferrite powder.

④ Electrode : External electrode (substrate)

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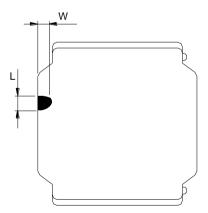


Characteristic Curve



Core Chipping:

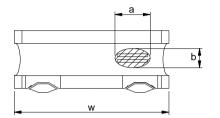
The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension



L	W
0.4mmMax.	0.4mmMax.

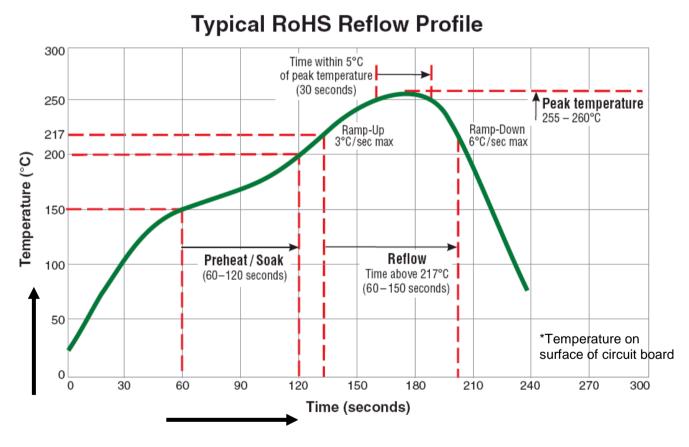


Exposed wire tolerance limit of coating resin part on product side Size of exposed wire occurring to coating resin is specified below.



- Width direction (dimension a): Acceptable when a<=w/2 Nonconforming when a>w/2
 Length direction (dimension b): Dimension b is not specified.
- When total area of exposed wire occurring to each sides is
 - not greater than 50% of coating resin area, that is acceptable.

Reflow Profile Chart (Reference):



(Table 1)

The products may be exposed to reflow soldering process of above profile up to two times.

Mechanical Performance /Environmental Test Performance Specifications: (WLPN202012 series)

No.	Item	Test condition	Requirements					
1	Resistance to Deflection.	No damage.	The test samples shall be soldered to the test board by the reflow soldering conditions show in Table 1. As illustrated below, apply force in the direction of the Arrow indicatin until deflection of the test board Reaches to 2 mm. $10^{20}_{Force R230}$ $R5 \xrightarrow{10^{Force R230}_{Force R230}}$ $R5 \xrightarrow{10^{Force R230}_{Force R230}}$ $R5 \xrightarrow{10^{Force R230}_{Force R230}}$ $R5 \xrightarrow{10^{Force R230}_{Force R230}}$ $R5 \xrightarrow{10^{Force R230}_{Force R230}}$ Land dimensions					
			Solder cream thickr	0x40x10 Unit: mm I: glass epoxy-resin iess:0.1				
2	Adhesion of Terminal Electrode.	Shall not come off PC board.	The test samples sh soldering conditions					
			Applied force: 10 N to X and Y directions Duration: 5 s. Solder cream thickness:0.1 mm. (Refer to recommended Land Pattern Dimensions Defined in "Precaution".)					
3	Body strength.	No damage.	Applied force :20 N. Duration :10 s.					
	Resistance to Vibration.	△L/L:within±10% No abnormality observed In appearance.		hall be soldered to the test board by the reflow ns shown in Table 1.Then it shall be submitted litions.				
4			Frequency range	10Hz~55Hz				
			Total Amplitude	1.5mm(May not exceed acceleration 196 m/S2)				
			Sweeping Method10Hz to 55Hz to 10 Hz for 1 min.					
			Time	For 2 hours on each X, Y, and Z axis.				
5	Resistance to Soldering heat (Reflow).	△L/L:within±10% No abnormality observed In appearance.	The test sample shall be exposed to reflow oven at 230±5 deg C for 40 seconds, with peak temperature at 260±5 deg C for 5 seconds, 2 times. Test board thickness: 1.0 mm. Test board material: glass epoxy-resin.					

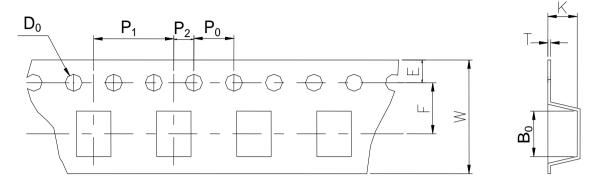
	Solder ability.	At least 90% of surface of terminal	molten s	t samples shall solder as shown	in below	table.	hen Immerse	d in	
c		electrode is covered by new		thanol solution	containing rosin 25%. 245±deg C				
6		solder.	Colder	Time	5±1.0 S.		_		
			Imme	ersing Speed		5 mm/s	_		
7	Temperature Characteristics.	△L/L:within±20% No abnormality observed in appearance.	-25 deg	ment of inducta C to +85 deg C. erence to induct ed.			-	_	
	Thermal shock.	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed at specified shown in below table in sequence. The temperature cycle shall be repeated 100 cycles.						
8				ns of steps for 1	-				
			Step	Temperat		Time(r			
			1	-40±3 deg	-		30±3		
			2	Room Ter			maximum		
			3 85±2 deg C 4 Room Temp			30±3 3 maximum			
	Low	\triangle L/L:within±10%	The test samples shall be soldered to the test board by the reflow					eflow	
9	Temperature life Test.	No abnormality observed in appearance.	y soldering conditions shown in Table 1. After that, the test samples shall be placed at test conditions in below table.						
			Ten						
				Time	500 4	-24/-0 h			
40	Loading at high temperature life test.	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and applied the rated current continuously as shown in below table.						
10			r	nperature	85±	2 deg C			
			Appl	ied current		d current to Page 3)			
				Time		⊦24/-0 h			
11	Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.							
			F	lumidity	90~	95%RH			
				Time		⊦24/-0 h			
12	Loading under Damp heat life test. △L/L:within±10% No abnormality observed in appearance. The test samples shall be soldered to the test board by the refision of the test soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at spitemperature and humidity and applied the rated current continuas shown in below table. 12 Temperature 60±2 deg C								
12				lumidity		90~95%RH			
				lied current	Rated c				
				Time		ed current (Refer to Page 3) 500+24/-0 h			
				-					

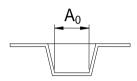
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Tape & Reel Packaging Dimensions:

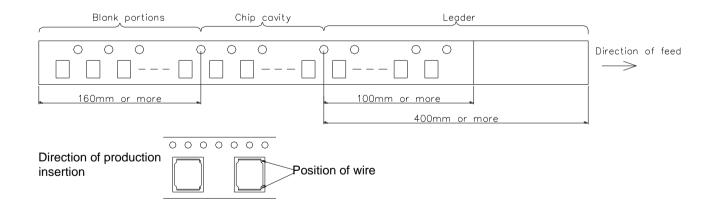
Dimensions Unit: mm





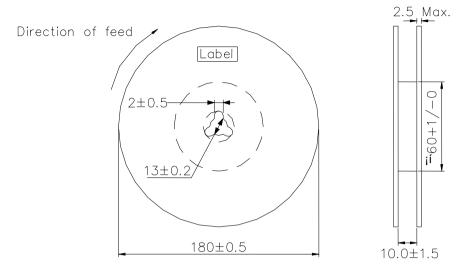
Ao	Bo	W	F	Е	P 1	P ₂	Po	Do	Т	K
2.2 ±0.09	2.2 ±0.09	8.0 ±0.2	3.5 ±0.1	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0± 0.1	Ф1.5 +0.1 -0	0.25 ±0.05	1.3 ±0.05

Direction of rolling



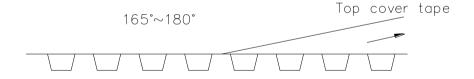


Reel



Label position:on the opposite sie of sprocket holes side of reel

Top tape strength



Peel-off strength: 0.1N~0.7N Peel-off angle:165°~180° Peel-off speed: 300mm/mm

Quantity per reel : 2.5K pcs